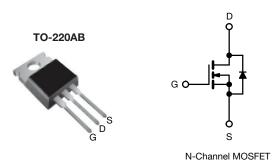


# **Power MOSFET**



| PRODUCT SUMMARY          |                            |  |  |  |  |
|--------------------------|----------------------------|--|--|--|--|
| V <sub>DS</sub> (V)      | 400                        |  |  |  |  |
| $R_{DS(on)}(\Omega)$     | V <sub>GS</sub> = 10 V 3.6 |  |  |  |  |
| Q <sub>g</sub> max. (nC) | 17                         |  |  |  |  |
| Q <sub>gs</sub> (nC)     | 3.4                        |  |  |  |  |
| Q <sub>gd</sub> (nC)     | 8.5                        |  |  |  |  |
| Configuration            | Single                     |  |  |  |  |

## **FEATURES**

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <a href="https://www.vishay.com/doc?99912"><u>www.vishay.com/doc?99912</u></a>

#### Note

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

#### **DESCRIPTION**

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

| ORDERING INFORMATION            |               |  |  |  |  |
|---------------------------------|---------------|--|--|--|--|
| Package                         | TO-220AB      |  |  |  |  |
| Lead (Pb)-free                  | IRF710PbF     |  |  |  |  |
| Lead (Pb)-free and halogen-free | IRF710PbF-BE3 |  |  |  |  |

| PARAMETER  |                         |                         | SYMBOL                            | LIMIT       | UNIT     |
|--|-------------------------|-------------------------|-----------------------------------|-------------|----------|
| Drain-source voltage   |                         |                         | V <sub>DS</sub>                   | 400         | V        |
| Gate-source voltage  |                         |                         | $V_{GS}$                          | ± 20        | v        |
| Continuous drain current   | V <sub>GS</sub> at 10 V | T <sub>C</sub> = 25 °C  | ,                                 | 2.0         | А        |
| Continuous drain current   |                         | T <sub>C</sub> = 100 °C | I <sub>D</sub>                    | 1.2         |          |
| Pulsed drain current <sup>a</sup>                                  |                         |                         | I <sub>DM</sub>                   | 6.0         |          |
| Linear derating factor   |                         |                         |                                   | 0.29        | W/°C     |
| Single pulse avalanche energy <sup>b</sup>                         |                         |                         | E <sub>AS</sub>                   | 120         | mJ       |
| Repetitive avalanche current a                                     |                         |                         | I <sub>AR</sub>                   | 2.0         | Α        |
| Repetitive avalanche energy <sup>a</sup>                           |                         |                         | E <sub>AR</sub>                   | 3.6         | mJ       |
| Maximum power dissipation $T_C = 25  ^{\circ}C$                    |                         |                         | P <sub>D</sub>                    | 36          | W        |
| Peak diode recovery dV/dt c  |                         |                         | dV/dt                             | 4.0         | V/ns     |
| Operating junction and storage temperature range                   |                         |                         | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C       |
| Soldering recommendations (peak temperature) <sup>d</sup> For 10 s |                         |                         |                                   | 300         |          |
| Mounting torque  | 6-32 or M3 screw        |                         |                                   | 10          | lbf ⋅ in |
| Mounting torque  |                         |                         |                                   | 1.1         | N⋅m      |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b.  $V_{DD}$  = 50 V, starting  $T_J$  = 25 °C, L = 52 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 2.0 A (see fig. 12)
- c.  $I_{SD} \le 2.0$  A,  $dI/dt \le 40$  A/ $\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C
- d. 1.6 mm from case



# Vishay Siliconix

| THERMAL RESISTANCE RATINGS          |                   |      |      |      |  |  |
|-------------------------------------|-------------------|------|------|------|--|--|
| PARAMETER                           | SYMBOL            | TYP. | MAX. | UNIT |  |  |
| Maximum junction-to-ambient         | R <sub>thJA</sub> | -    | 62   |      |  |  |
| Case-to-sink, flat, greased surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |  |  |
| Maximum junction-to-case (drain)    | R <sub>thJC</sub> | -    | 3.5  |      |  |  |

| PARAMETER                                 | SYMBOL                | TES  | MIN.   | TYP.     | MAX.      | UNIT                  |                  |
|---|-----------------------|--|--|----------|-----------|-----------------------|------------------|
| Static                                    |                       |  |  |          |           |                       |                  |
| Drain-source breakdown voltage            | V <sub>DS</sub>       | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$  |  | 400      | -         | -                     | V                |
| V <sub>DS</sub> temperature coefficient   | $\Delta V_{DS}/T_{J}$ | Reference  | e to 25 °C, I <sub>D</sub> = 1 mA                                    | -        | 0.47      | -                     | V/°C             |
| Gate-source threshold voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> =  | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA                          | 2.0      | -         | 4.0                   | V                |
| Gate-source leakage                       | I <sub>GSS</sub>      | ,  | V <sub>GS</sub> = ± 20 V   |          | -         | ± 100                 | nA               |
| Zava cata valtaca dvain august            |                       | V <sub>DS</sub> =  | V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V                       |          | -         | 25                    |                  |
| Zero gate voltage drain current           | I <sub>DSS</sub>      | V <sub>DS</sub> = 320V   | , V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C                     | -        | -         | 250                   | μA               |
| Drain-source on-state resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V   | I <sub>D</sub> = 1.2 A <sup>b</sup>                                  | -        | -         | 3.6                   | Ω                |
| Forward transconductance                  | 9 <sub>fs</sub>       | V <sub>DS</sub> =  | 50 V, I <sub>D</sub> = 1.2 A <sup>b</sup>                            | 1.0      | -         | -                     | S                |
| Dynamic                                   |                       |  |  |          |           |                       |                  |
| Input capacitance                         | C <sub>iss</sub>      |  | $V_{GS} = 0 V$   | -        | 170       | -                     | pF               |
| Output capacitance                        | C <sub>oss</sub>      |  | $V_{DS} = 25 \text{ V},$   | -        | 34        | -                     |                  |
| Reverse transfer capacitance              | C <sub>rss</sub>      | f = 1.   | .0 MHz, see fig. 5   | -        | 6.3       | -                     |                  |
| Total gate charge                         | Qg                    |  |  | -        | -         | 17                    | nC               |
| Gate-source charge                        | Q <sub>gs</sub>       | V <sub>GS</sub> = 10 V   | $I_D = 2.0 \text{ A}, V_{DS} = 320 \text{ V}$<br>see fig. 6 and 13 b | -        | -         | 3.4                   |                  |
| Gate-drain charge                         | Q <sub>gd</sub>       |  | See fig. 6 dita 16   | -        | -         | 8.5                   |                  |
| Turn-on delay time                        | t <sub>d(on)</sub>    | $V_{DD}$ = 200 V, $I_{D}$ = 2.0 A, $R_{g}$ = 24 $\Omega$ , $R_{D}$ = 95 $\Omega$ see fig. 10 b |  | -        | 8.0       | -                     | - ns             |
| Rise time                                 | t <sub>r</sub>        |  |  | -        | 9.9       | -                     |                  |
| Turn-off delay time                       | t <sub>d(off)</sub>   |  |  | -        | 21        | -                     |                  |
| Fall time                                 | t <sub>f</sub>        |  |  | -        | 11        | -                     |                  |
| Gate input resistance                     | R <sub>g</sub>        | f = 1 MHz, open drain  |  | 1.7      | -         | 11.2                  | Ω                |
| Internal drain inductance                 | $L_D$                 | 6 mm (0.25   | Between lead,<br>6 mm (0.25") from                                   |          | 4.5       | -                     | -11              |
| Internal source inductance                | L <sub>S</sub>        | package and center of die contact  |  | -        | 7.5       | -                     | - nH             |
| Drain-Source Body Diode Characteristic    | es                    |  |  |          | •         | •                     |                  |
| Continuous source-drain diode current     | I <sub>S</sub>        | MOSFET symbol showing the integral reverse p - n junction diode                                |  | -        | -         | 2.0                   |                  |
| Pulsed diode forward current <sup>a</sup> | I <sub>SM</sub>       |  |  | -        | -         | 6.0                   | A A              |
| Body diode voltage                        | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 2.0 A, V <sub>GS</sub> = 0 V b                        |  | -        | -         | 1.6                   | V                |
| Body diode reverse recovery time          | t <sub>rr</sub>       | T.1 =  | 25 °C, I <sub>F</sub> = 2.0 A,                                       | -        | 240       | 540                   | ns               |
| Body diode reverse recovery charge        | Q <sub>rr</sub>       | $dI/dt = 100 \text{ A/}\mu\text{s}^{\text{b}}$   |  | -        | 0.85      | 1.6                   | μC               |
| Forward turn-on time                      | t <sub>on</sub>       | Intrinsic tu   | rn-on time is negligible (turn                                       | on is do | minated b | by L <sub>S</sub> and | L <sub>D</sub> ) |

## Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

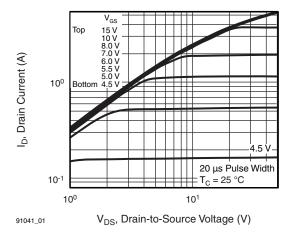


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

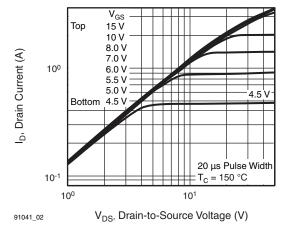


Fig. 2 - Typical Output Characteristics,  $T_C$  = 150 °C

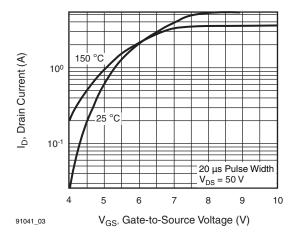


Fig. 3 - Typical Transfer Characteristics

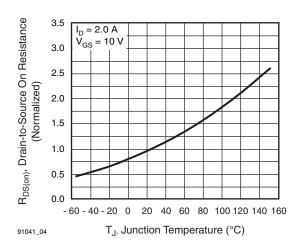


Fig. 4 - Normalized On-Resistance vs. Temperature

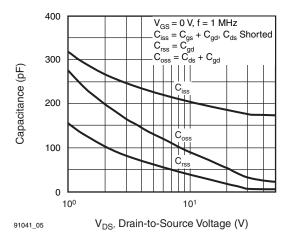


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

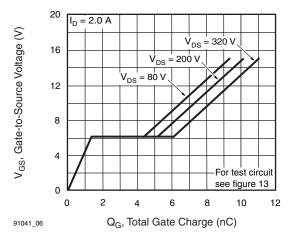


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



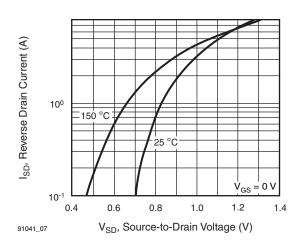


Fig. 7 - Typical Source-Drain Diode Forward Voltage

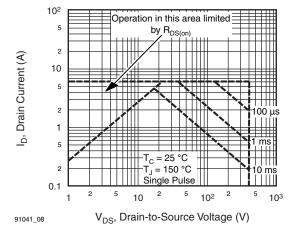


Fig. 8 - Maximum Safe Operating Area

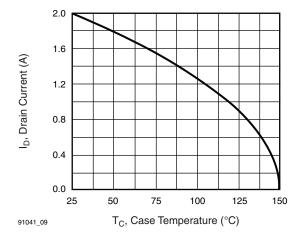


Fig. 9 - Maximum Drain Current vs. Case Temperature

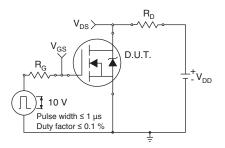


Fig. 10a - Switching Time Test Circuit

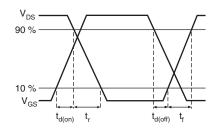


Fig. 10b - Switching Time Waveforms



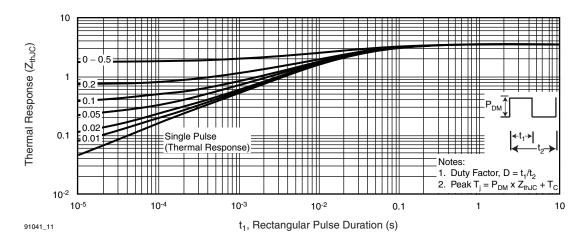


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

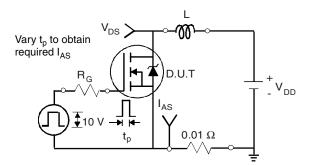


Fig. 12a - Unclamped Inductive Test Circuit

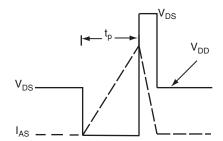


Fig. 12b - Unclamped Inductive Waveforms

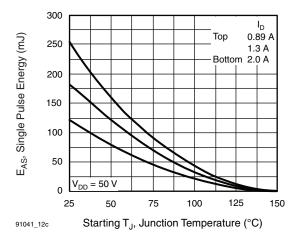


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



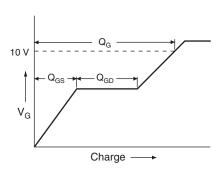


Fig. 13a - Basic Gate Charge Waveform

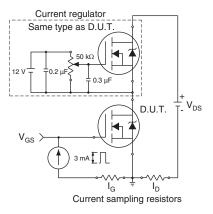
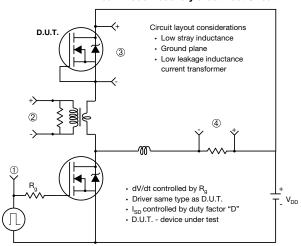


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



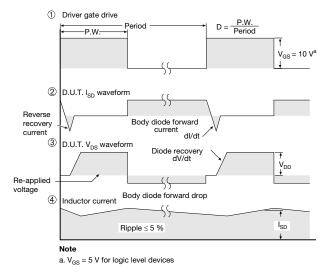


Fig. 14 - For N-Channel

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# TO-220-1



| DIM  | MILLIN | IETERS | INCHES |       |  |
|--|--------|--------|--------|-------|--|
| DIM.   | MIN.   | MAX.   | MIN.   | MAX.  |  |
| Α  | 4.24   | 4.65   | 0.167  | 0.183 |  |
| b  | 0.69   | 1.02   | 0.027  | 0.040 |  |
| b(1)   | 1.14   | 1.78   | 0.045  | 0.070 |  |
| С  | 0.36   | 0.61   | 0.014  | 0.024 |  |
| D  | 14.33  | 15.85  | 0.564  | 0.624 |  |
| E  | 9.96   | 10.52  | 0.392  | 0.414 |  |
| е  | 2.41   | 2.67   | 0.095  | 0.105 |  |
| e(1)   | 4.88   | 5.28   | 0.192  | 0.208 |  |
| F  | 1.14   | 1.40   | 0.045  | 0.055 |  |
| H(1)   | 6.10   | 6.71   | 0.240  | 0.264 |  |
| J(1)   | 2.41   | 2.92   | 0.095  | 0.115 |  |
| L  | 13.36  | 14.40  | 0.526  | 0.567 |  |
| L(1)   | 3.33   | 4.04   | 0.131  | 0.159 |  |
| ØР   | 3.53   | 3.94   | 0.139  | 0.155 |  |
| Q  | 2.54   | 3.00   | 0.100  | 0.118 |  |
| ECN: X15-0364-Rev. C, 14-Dec-15<br>DWG: 6031 |        |        |        |       |  |

## Note

 $\bullet$   $M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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